

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

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Assignee:

Nanometrics Incorporated ROOM

Title:

Apparatus And Method For The Measurement Of Diffracting Structures

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09/670,000

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COMMISSIONER FOR PATENTS Washington, D. C. 20231

INFORMATION DISCLOSURE STATEMENT **UNDER 37 CFR § 1.97(b)**

Dear Sir:

Pursuant to 37 C.F.R. § 1.56, § 1.97 and § 1.98, the documents listed on the accompanying PTO Form-1449 are called to the attention of the Examiner for the above patent application. In particular, Applicants call U.S. 5,963,329 by Conrad et al. to the Examiner's attention. Copies of these documents are enclosed.

Citation of these documents shall not be construed as:

- an admission that the documents are necessarily prior art with respect to the instant invention;
 - 2. a representation that a search has been made; or
- an admission that the information cited herein is, or is considered to be, material to patentability as defined in $\S 1.56(b)$.

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, Washington, D.C. 20231, on April 2, 2001.

Attornéy for Applicants

Respectfully submitted,

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